

# 4V Drive Nch MOSFET

## RXR035N03

### ● Structure

Silicon N-channel MOSFET

### ● Features

- 1) Low on-resistance.
- 2) Built-in G-S Protection Diode.
- 3) Small Surface Mount Package (TSMT3).

### ● Application

Switching

### ● Packaging specifications

| Type      | Package                      | Taping |
|-----------|------------------------------|--------|
|           | Code                         | TCL    |
|           | Basic ordering unit (pieces) | 3000   |
| RXR035N03 |                              | ○      |

### ● Absolute maximum ratings (Ta = 25°C)

| Parameter                    |            | Symbol      | Limits      | Unit |
|------------------------------|------------|-------------|-------------|------|
| Drain-source voltage         |            | $V_{DSS}$   | 30          | V    |
| Gate-source voltage          |            | $V_{GSS}$   | ±20         | V    |
| Drain current                | Continuous | $I_D$       | ±3.5        | A    |
|                              | Pulsed     | $I_{DP}$ *1 | ±12         | A    |
| Source current (Body Diode)  | Continuous | $I_S$       | 0.8         | A    |
|                              | Pulsed     | $I_{SP}$ *1 | 12          | A    |
| Power dissipation            |            | $P_D$ *2    | 1.0         | W    |
| Channel temperature          |            | $T_{ch}$    | 150         | °C   |
| Range of storage temperature |            | $T_{stg}$   | -55 to +150 | °C   |

\*1  $P_w \leq 10 \mu s$ , Duty cycle  $\leq 1\%$

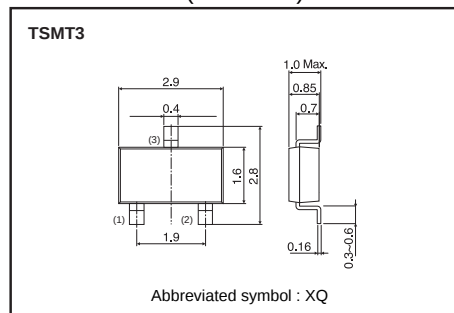
\*2 Mounted on a ceramic board.

### ● Thermal resistance

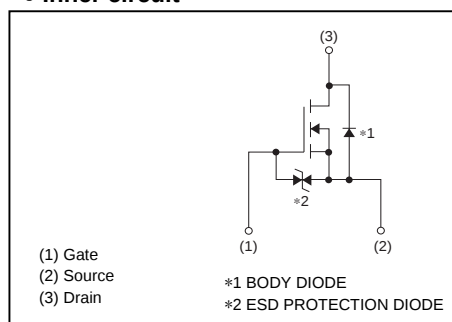
| Parameter          | Symbol           | Limits | Unit   |
|--------------------|------------------|--------|--------|
| Channel to Ambient | $R_{th(ch-a)}$ * | 125    | °C / W |

\*Mounted on a ceramic board.

### ● Dimensions (Unit : mm)



### ● Inner circuit



## ● Electrical characteristics (Ta = 25°C)

| Parameter                               | Symbol         | Min. | Typ. | Max.     | Unit       | Conditions                       |
|-----------------------------------------|----------------|------|------|----------|------------|----------------------------------|
| Gate-source leakage                     | $I_{GSS}$      | -    | -    | $\pm 10$ | $\mu A$    | $V_{GS} = \pm 20V, V_{DS} = 0V$  |
| Drain-source breakdown voltage          | $V_{(BR)DSS}$  | 30   | -    | -        | V          | $I_D = 1mA, V_{GS} = 0V$         |
| Zero gate voltage drain current         | $I_{DSS}$      | -    | -    | 1        | $\mu A$    | $V_{DS} = 30V, V_{GS} = 0V$      |
| Gate threshold voltage                  | $V_{GS(th)}$   | 1.0  | -    | 2.5      | V          | $V_{DS} = 10V, I_D = 1mA$        |
| Static drain-source on-state resistance | $R_{DS(on)}^*$ | -    | 35   | 50       | m $\Omega$ | $I_D = 3.5A, V_{GS} = 10V$       |
|                                         |                | -    | 45   | 65       |            | $I_D = 3.5A, V_{GS} = 4.5V$      |
|                                         |                | -    | 50   | 70       |            | $I_D = 3.5A, V_{GS} = 4.0V$      |
| Forward transfer admittance             | $ Y_{fs} ^*$   | 2.2  | -    | -        | S          | $I_D = 3.5A, V_{DS} = 10V$       |
| Input capacitance                       | $C_{iss}$      | -    | 180  | -        | pF         | $V_{DS} = 10V$                   |
| Output capacitance                      | $C_{oss}$      | -    | 70   | -        | pF         | $V_{GS} = 0V$                    |
| Reverse transfer capacitance            | $C_{rss}$      | -    | 35   | -        | pF         | $f = 1MHz$                       |
| Turn-on delay time                      | $t_{d(on)}^*$  | -    | 10   | -        | ns         | $I_D = 1.7A, V_{DD} \approx 15V$ |
| Rise time                               | $t_r^*$        | -    | 25   | -        | ns         | $V_{GS} = 10V$                   |
| Turn-off delay time                     | $t_{d(off)}^*$ | -    | 25   | -        | ns         | $R_L = 8.8\Omega$                |
| Fall time                               | $t_f^*$        | -    | 7    | -        | ns         | $R_G = 10\Omega$                 |
| Total gate charge                       | $Q_g^*$        | -    | 3.3  | -        | nC         | $I_D = 3.5A$                     |
| Gate-source charge                      | $Q_{gs}^*$     | -    | 1.0  | -        | nC         | $V_{DD} \approx 15V$             |
| Gate-drain charge                       | $Q_{gd}^*$     | -    | 1.0  | -        | nC         | $V_{GS} = 5V$                    |

\*Pulsed

## ● Body diode characteristics (Source-Drain) (Ta = 25°C)

| Parameter       | Symbol     | Min. | Typ. | Max. | Unit | Conditions                |
|-----------------|------------|------|------|------|------|---------------------------|
| Forward Voltage | $V_{SD}^*$ | -    | -    | 1.2  | V    | $I_S = 3.5A, V_{GS} = 0V$ |

\*Pulsed

# ●Electrical characteristic curves (Ta=25°C)

Fig.1 Typical Output Characteristics( I )

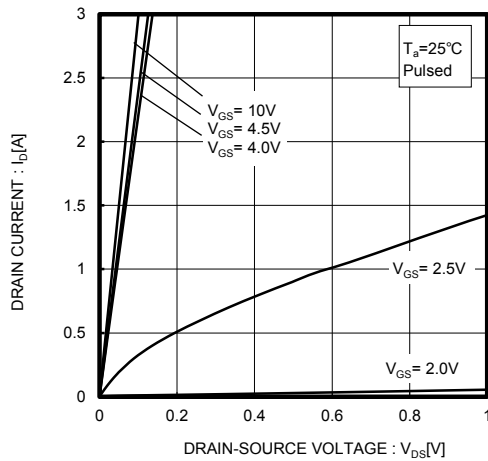


Fig.2 Typical Output Characteristics( II )

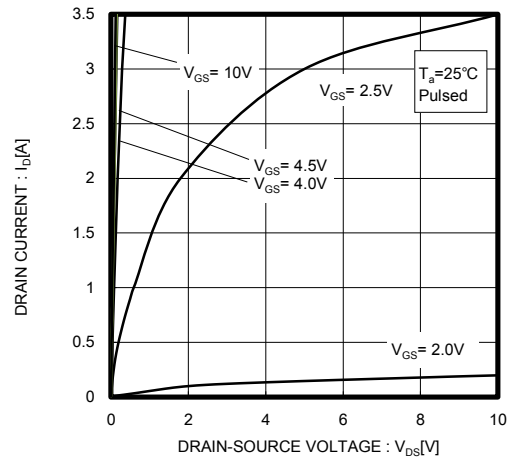


Fig.3 Typical Transfer Characteristics

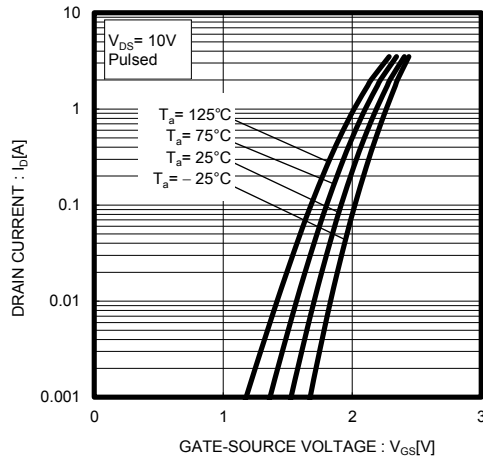


Fig.4 Static Drain-Source On-State Resistance vs. Drain Current( I )

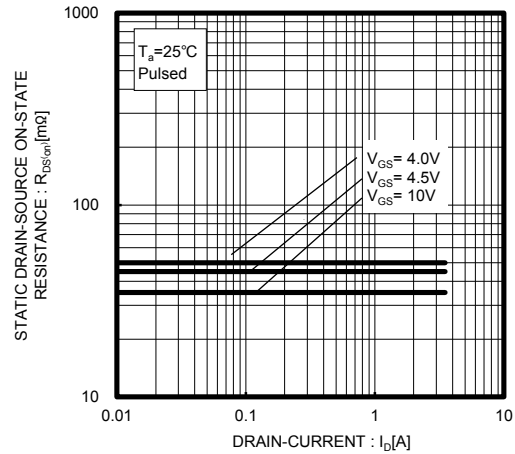


Fig.5 Static Drain-Source On-State Resistance vs. Drain Current( II )

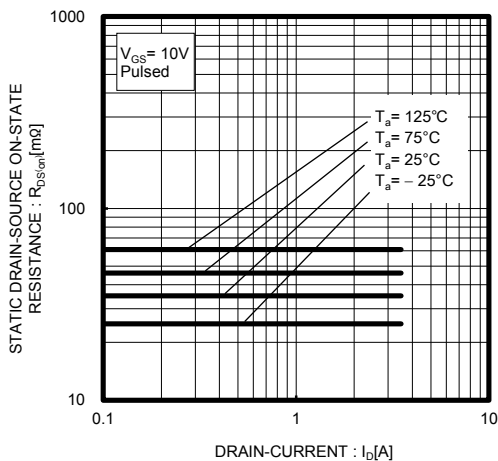


Fig.6 Static Drain-Source On-State Resistance vs. Drain Current( III )

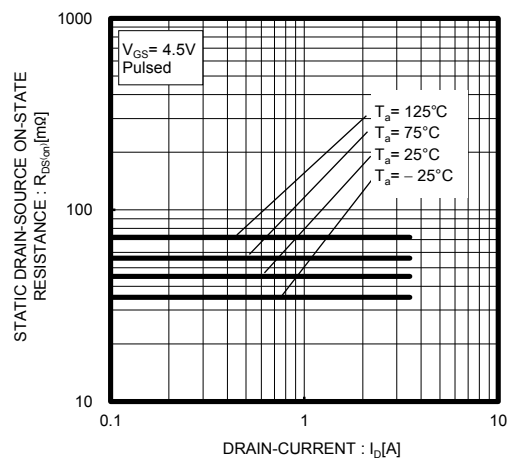


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current (IV)

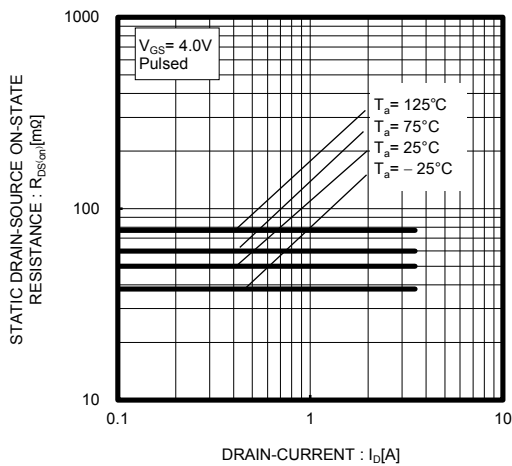


Fig.8 Forward Transfer Admittance vs. Drain Current

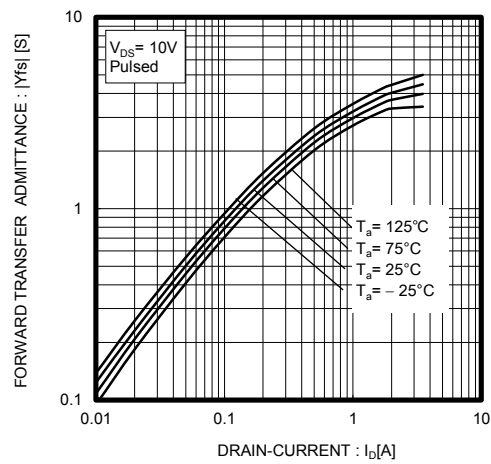


Fig.9 Reverse Drain Current vs. Source-Drain Voltage

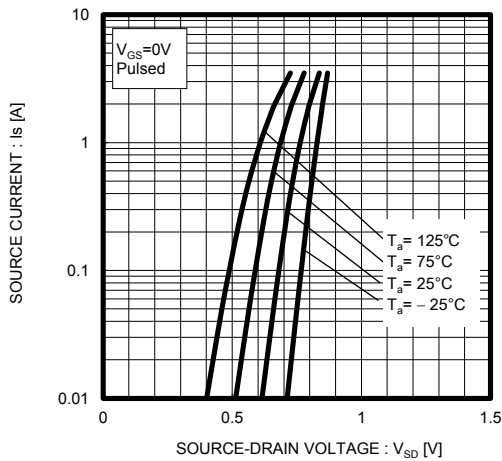


Fig.10 Static Drain-Source On-State Resistance vs. Gate Source Voltage

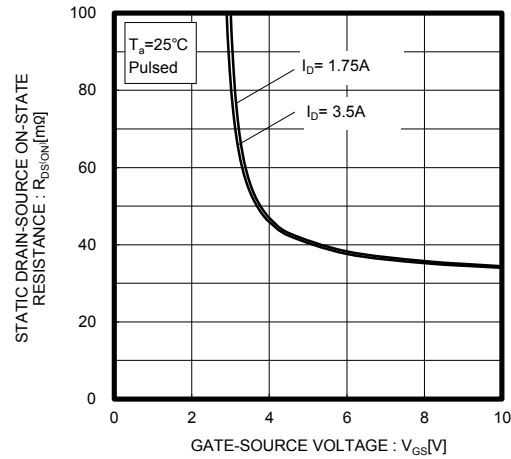


Fig.11 Switching Characteristics

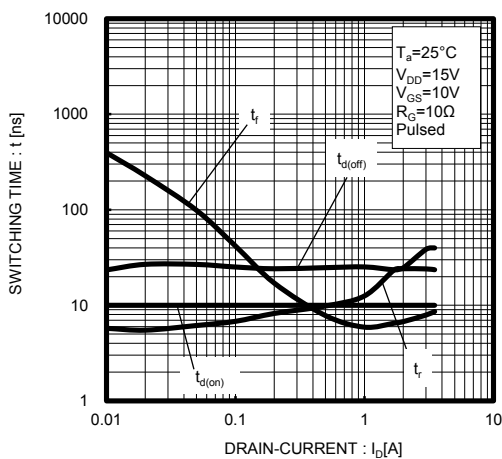


Fig.12 Dynamic Input Characteristics

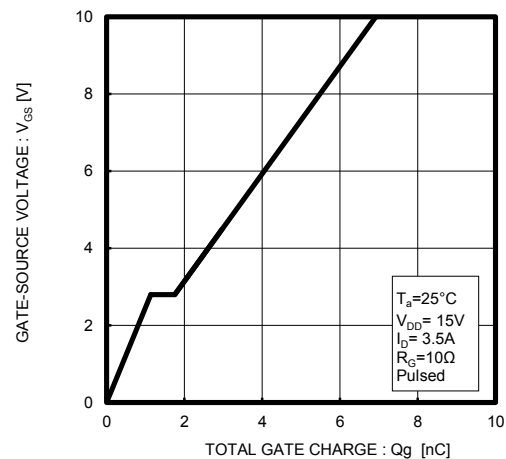


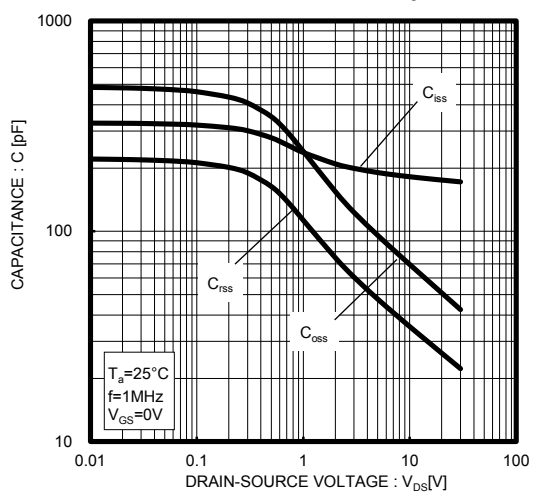
Fig.13 Typical Capacitance  
vs. Drain-Source Voltage

Fig.14 Maximum Safe Operating Area

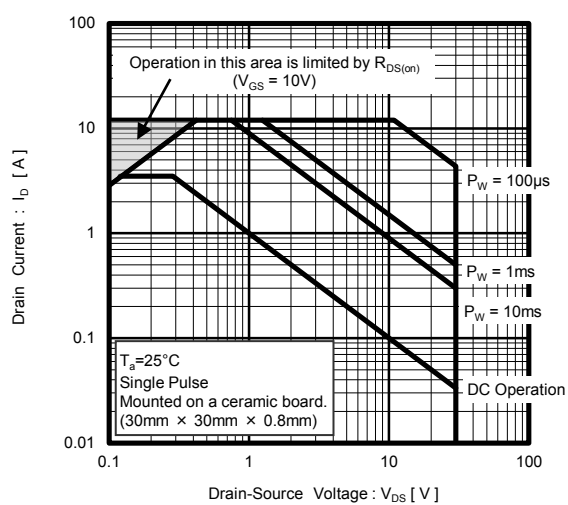
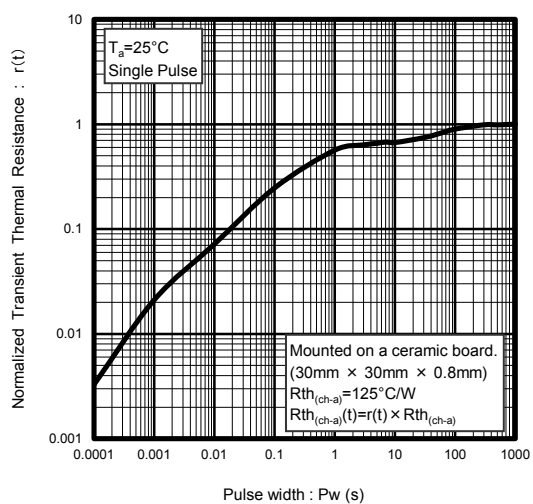


Fig.15 Normalized Transient Thermal Resistance v.s. Pulse Width



## ● Measurement circuits

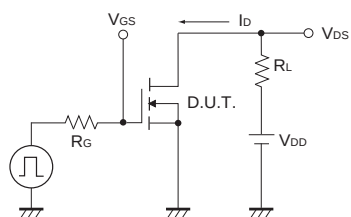


Fig.1-1 Switching Time Measurement Circuit

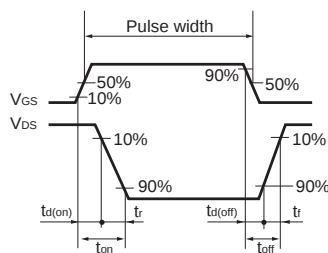


Fig.1-2 Switching Waveforms

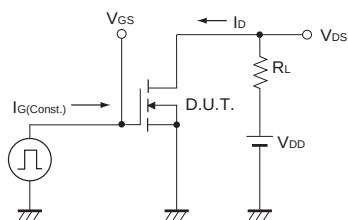


Fig.2-1 Gate Charge Measurement Circuit

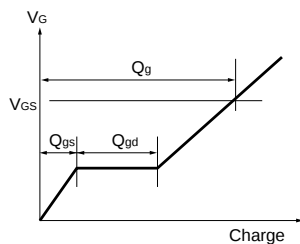


Fig.2-2 Gate Charge Waveform

## ● Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

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